## Search Notes



Application/Control No.	on/Control No. Applicant(s)/Patent Under Reexamination	
10757650	MAUPIN, PATRICK EVAN	
Examiner	Art Unit	
Flores, Leon	2611	

SEARCHED					
Class	Subclass	Date	Examiner		
375	295, 377, 222, 220	2/26/2007	LF		
370	276	2/26/2007	LF		
455	39, 73, 91	2/26/2007	LF		

SEARCH NOTES				
Search Notes	Date	Examiner		
Consulted with SPE David Payne in regards to the patentability of claim 1.	2/27/2007	LF		
Checked for Double patenting.	2/26/2007	LF		

INTERFERENCE SEARCH					
Subclass	Date	Examine			

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